Abstract Submitted for the MAR11 Meeting of The American Physical Society

Van der Waals epitaxial growth and transport properties of Bi2Se3 thin films<sup>1</sup> JIAN-HAO CHEN<sup>2</sup>, JACK HELLERSTEDT, WILLIAM CULLEN, MICHAEL FUHRER, Dept. of Physics, Materials Research Science and Engineering Center and Center for Nanophysics and Advanced Materials, Univ. of Maryland, College Park — Thin films of Bi<sub>2</sub>Se<sub>3</sub> with high carrier mobility are grown with van der Waals epitaxy method in ultra-high vacuum environment on single crystal Sapphire (0001) and single crystal SrTiO<sub>3</sub> (111) surfaces. *Ex-situ* transport measurement revealed weak-antilocalization-like behavior at small out-of-plane magnetic field (B<sub>o</sub>) and non-linear Hall conductance versus Bo. The carrier concentration of the Bi<sub>2</sub>Se<sub>3</sub> can be substantially tuned with applied electric field through the SrTiO<sub>3</sub> substrate.

<sup>1</sup>This work was supported by the UMD NSF-MRSEC grant no. DMR 05-20741. <sup>2</sup>Present address: Department of Physics, UC Berkeley and Materials Sciences Division, Lawrence Berkeley National Laboratory, Berkeley, CA 94720, USA

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Date submitted: 30 Nov 2010

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